

Issue Classification 	Application No.	Applicant(s)
	10/749,489	JWA, SEUNG HEE
	Examiner	Art Unit
	Lee, Calvin	2818
		20063/10020

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
438	260	257	341
INTERNATIONAL CLASSIFICATION			
H	0	1	L
			21/336
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 calomlee (Assistant Examiner)		6/9/05 (Date)	 David Neims Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date) 6/9/05
 G. Stanley (Legal Instruments Examiner)		6-13-05 (Date)	
Total Claims Allowed: 8			
		O.G. Print Claim(s)	O.G. Print Fig.
		1	4F & 4I

Claims renumbered in the same order as presented by applicant

Final	Original														
1		31		61		91		121		151		181		152	
2		32		62		92		122		152		182		153	
3		33		63		93		123		153		183		154	
4		34		64		94		124		154		184		155	
5		35		65		95		125		155		185		156	
6		36		66		96		126		156		186		157	
7		37		67		97		127		157		187		158	
8		38		68		98		128		158		188		159	
9		39		69		99		129		159		189		160	
10		40		70		100		130		160		190		161	
11		41		71		101		131		161		191		162	
12		42		72		102		132		162		192		163	
13		43		73		103		133		163		193		164	
14		44		74		104		134		164		194		165	
15		45		75		105		135		165		195		166	
16		46		76		106		136		166		196		167	
17		47		77		107		137		167		197		168	
18		48		78		108		138		168		198		169	
19		49		79		109		139		169		199		170	
20		50		80		110		140		170		200		171	
21		51		81		111		141		171		201		172	
22		52		82		112		142		172		202		173	
23		53		83		113		143		173		203		174	
24		54		84		114		144		174		204		175	
25		55		85		115		145		175		205		176	
26		56		86		116		146		176		206		177	
27		57		87		117		147		177		207		178	
28		58		88		118		148		178		208		179	
29		59		89		119		149		179		209		180	
30		60		90		120		150		180		210			